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Joint Reconstruction of X-Ray Fluorescence and Transmission Tomography

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Abstract: X-ray fluorescence tomography is based on the detection of fluorescence x-ray photons produced following x-ray absorption while a specimen is rotated; it provides information on the 3D distribution of selected elements within a sample. One limitation in the quality of sample recovery is the separation of elemental signals due to the finite energy resolution of the detector. Another limitation is the effect of self-absorption, which can lead to inaccurate results with dense samples. To recover the true elemental map, we combine x-ray fluorescence detection with a second data modality: conventional x-ray transmission tomography using either absorption or phase contrast. By using these combined signals in a nonlinear optimization-based approach, we obtain an improved quantitative reconstruction of the spatial distribution of most elements in the sample. Compared with single-modality inversion based on x-ray fluorescence alone, this joint inversion approach reduces ill-posedness and results in improved elemental quantification and better correction of self-absorption.

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References and links

1. Introduction

The use of characteristic x-ray emission lines to distinguish between different chemical elements in a specimen goes back to the birth of quantum mechanics [1]. X-ray fluorescence can be stimulated by energy transfer from electron or proton beams, but the best combination of sensitivity and minimum radiation damage is provided by using x-ray absorption [2–4] for this purpose. This is usually done in a scanning microscope mode, where a small x-ray beam spot is raster-scanned across the specimen while x-ray photons are collected by an energy dispersive detector that provides a measure of the energy of each emitted photon [5]. Following early demonstrations [6], x-ray fluorescence microscopy is now commonplace in many laboratories and in particular at a wide range of synchrotron radiation light source facilities worldwide. Because the x-ray beam from synchrotron light sources is usually linearly polarized in the horizontal direction, the energy dispersive detector is usually located at a position 90° in the horizontal from the incident beam so as to be centered on the direction of minimum elastic scattering as shown in Fig. 1 (other energy dispersive detector positions can be used [7], with various relative merits [8]). Because the depth of focus of the x-ray beam is usually large compared to the specimen size, one can treat the incident x-ray beam as a pencil beam of constant diameter and thus rotate the specimen to obtain a set of 2D projections from each x-ray fluorescence line for tomographic reconstruction [9, 10], even for elements present at low concentration such as trace elements in biological specimens [11].

A common approach is to collect the photon counts within predetermined energy windows, or to use per-pixel spectral fitting [12], so as to get immediate elemental concentration maps. These maps are then used in conventional tomographic reconstruction schemes, such as filtered back projection and iterative reconstruction techniques [13, 14]. A more recent approach has been to use a penalized maximum likelihood estimation method on the per-pixel spectra recorded by the energy dispersive detector for improved quantification and elemental separation [15]; we refer to this as full-spectrum analysis. A separate complication involves the correction of fluorescence self-absorption, where characteristic x-ray fluorescence photons emitted from one voxel in a 3D specimen might suffer absorption in specimen material that lies between this voxel and the energy dispersive detector. There have been interesting approaches to correct for self-absorption as will be discussed below, but these approaches have not been combined with full-spectrum analysis. In addition, phase contrast dominates over absorption contrast in transmission imaging using multi-keV x-rays [16, 17] and it can provide a superior imaging signal for the alignment of x-ray fluorescence tomography datasets when rotation stage run-out error is significant [18]. For these reasons, we consider here a combined approach that incorporates both full-spectrum fluorescence analysis, and transmission imaging using absorption and phase contrast, as part of an optimization-based approach to fluorescence tomography analysis by using a complete forward model of the x-ray imaging process.
Fig. 1: Top view of the geometry used in x-ray fluorescence microscopy. The x-ray beam is treated as a pencil beam in the z direction that is raster-scanned across the specimen in 1D in the x direction, and the specimen is then rotated before another image is acquired (successive 2D planes are imaged by motion of the 3D specimen in the y direction, into/out of the plane of this top view). The x-ray transmission signal (absorption or phase contrast) is recorded, and the x-ray fluorescence (XRF) signal is recorded over an angular range of $\Omega_v$ by using an energy dispersive detector located at 90° to the beam, in the direction of the elastic scattering minimum for a horizontally polarized x-ray beam. The grid overlay on the specimen shows its discretization with a pixel size of $L_v$; the set of pixels (in 2D; voxels in 3D) through which the XRF signal might undergo self-absorption in the specimen is indicated in orange.

2. Fluorescence Self-Absorption

We begin with a simple illustration of self-absorption. Consider a specimen that consists of a 200 $\mu$m diameter borosilicate glass cylinder with a 10 $\mu$m diameter tungsten wire off to one side, and a 10 $\mu$m gold wire off to another side (Fig. 2). The borosilicate glass was assumed to consist of 81% SiO$_2$, 13% B$_2$O$_3$, 3.5% Na$_2$O, 2% Al$_2$O$_3$, and 0.5% K$_2$O, with a density of 2.23 g/cm$^3$. If a chromatic x-ray focusing optic like a Fresnel zone plate is used to produce the x-ray pencil beam, a monochromatic x-ray beam should be used for scanning and its energy might be set to 12.1 keV to be well-separated in energy from the Au $L_{\beta_1}$ fluorescence line at 11.4 keV. As the specimen is rotated, one obtains x-ray transmission (XRT) sinograms based on the attenuation of 12.1 keV x rays in Si, W, and Au as shown at right in Fig. 2. The situation with the x-ray fluorescence (XRF) signal is different; when the x-ray beam is at the right edge of the Si cylinder, the Si $K_{\alpha_1}$ x-rays with 1.74 keV photon energy will have to traverse nearly 200 $\mu$m of Si before they reach the XRF detector located at left (Fig. 1). Since Table 1 shows that the absorption length of 1.74 keV x-rays is 1.66 $\mu$m in glass, the fraction of the signal reaching the XRF detector is only $\exp[-200/1.66] \approx 5 \times 10^{-53}$ so that essentially none of the Si XRF signal is detected in this case. In fact, only the Si XRF signal from the side nearest to the XRF detector is registered, so that from the Si XRF signal one cannot distinguish between a solid Si cylinder versus one that is hollowed out as shown in the bottom row of Fig. 2. The Au and W XRF signals can better traverse through the Si cylinder to reach the XRF detector, and moreover the 12.1 keV incident beam is also only partly absorbed so by combining all of these signals one can indeed distinguish between a solid and hollow Si cylinder.

Several methods have been used to correct for the self-absorption effect, including earlier approaches used for radionuclide emission tomography [19–21]. If one can measure the trans-
Table 1: X-ray absorption lengths $\mu^{-1}$ for silicon (Si), a borosilicate glass with a composition described in Sec. 2, tungsten (W), and gold (Au) at the energies of selected x-ray fluorescence lines (see also the spectrum in Fig. 10) and also for an incident x-ray energy of 12.1 keV. As can be seen, Si x-ray fluorescence in particular will be strongly self-absorbed according to the Lambert-Beer law of $I = I_0 \exp(-\mu t)$ for a material of thickness $t$. The x-ray attenuation coefficient $\mu_E$ for element $e$ at x-ray energy $E$ is just the inverse of the absorption length.
Fig. 2: Illustration of the x-ray fluorescence self-absorption effect, and how x-ray transmission can be used to recognize and correct for it. We show here a specimen composed of cylinders, or circles in this top view. The largest is of borosilicate glass (composition described in Sec. 2) with 200 μm diameter, followed by tungsten (W) with 10 μm diameter, and gold (Au) with 10 μm diameter. As 1D scans in beamlet positions τ are collected at successive specimen rotation angles θ, one builds up sinograms or (τ, θ) views of elemental x-ray fluorescence (XRF) signals such as the Si XRF signal shown in the middle, as well as 12.1 keV x-ray transmission (XRT) sinograms as shown at right (based on absorption contrast; phase contrast images can also be used). If there is no self-absorption of the fluorescence signal, one obtains a Si XRF sinogram as shown in the top row, where the incident x-ray beam is partially absorbed in the small W and Au wires as they rotate into positions to intercept the incident beam before it reaches the glass cylinder. However, the 200 μm diameter glass cylinder is large compared to the 1.66 μm absorption length of Si Kα1 x-rays in the glass as shown in Table 1, so that a fraction \(1 - \exp\left[-200/1.66\right] \approx 1 - 5 \times 10^{-53}\) of the Si XRF signal will be self-absorbed in the rod. As a result, the Si XRF signal will be detected mainly when the incident beam is at the left side of the scan; this leads to the Si XRF sinogram shown in the middle row (the sinogram also shows absorption of the Si XRF signal in the W and Au wires as they rotate through positions where they partly obscure the XRF detector’s view of the Si cylinder). In the bottom row we show the case where the glass cylinder is hollow, with a wall thickness of 30 μm that is nevertheless large compared to the 1.66 μm absorption length of Si XRF photons; in this case the Si XRF sinogram is almost unchanged, but the XRT sinogram is clearly different. By using the combined information of the fluorescence (XRF) and transmission (XRT) sinograms, one can in principle obtain a better reconstructed image of the specimen in the case of strong fluorescence self-absorption.
We start from an earlier approach [32], which we extend considerably here. We use $\theta \in \Theta$ and $\tau \in \mathcal{T}$ to denote, respectively, the index of the x-ray beam angle and discretized beamlet from a collection of $|\Theta|$ angles and $|\mathcal{T}|$ beamlets. The set $\mathcal{Y}$ denotes the collection of $|\mathcal{Y}|$ spatial voxels used to discretize the reconstructed sample. By $L = [L_\theta^\tau \, | \, \mathcal{T}]$, we denote the intersection lengths (in cm) of beamlet $(\theta, \tau)$ with the voxel $v \in \mathcal{Y}$. We use $\mathcal{E}$ to denote the collection of $|\mathcal{E}|$ possible elements and $\mu_e^E$ to denote the mass attenuation coefficient (in cm$^2$g$^{-1}$) of element $e$ at beam incident energy $E$. Our goal is to recover $\mathcal{W} = [\mathcal{W}_{\theta,\tau}]$, the concentration (in g cm$^{-3}$) of element $e$ in voxel $v$.

3.1. XRT Imaging Model

A conventional way (see, e.g., [33]) to model the XRT projection $F_{\theta,\tau}^T$ (in counts/sec) of a sample from beamlet $(\theta, \tau)$ is

$$F_{\theta,\tau}^T(\bar{\mu}^E) = I_0 \exp \left\{ -\sum_{v} L_{\theta,\tau}^v \mu_v^E \right\}, \quad (3.1)$$

where $I_0$ is the incident x-ray intensity (in counts/sec) and $\bar{\mu}^E = [\mu_v^E]$ is the linear attenuation absorption coefficient (in cm$^{-1}$) at incident energy $E$.

To better explore the correlation of XRF and XRT and to link these two data modalities by the common variable $\mathcal{W}$, we note that the coefficients $\bar{\mu}^E$ depend on $\mathcal{W}$ by way of $\bar{\mu}^E = \sum_{s} \mathcal{W}_{\theta,\tau} \mu_v^E$.

Incorporating this fact in Eq. 3.1, we obtain a new XRT forward model based on $\mathcal{W}$

$$F_{\theta,\tau}^T(\mathcal{W}) = I_0 \exp \left\{ -\sum_{v} L_{\theta,\tau}^v \mu_v^E \mathcal{W}_{\theta,\tau} \right\}. \quad (3.2)$$

To obtain a simple proportional relationship, we divide both sides of Eq. 3.2 by $I_0$ and then take the logarithm to obtain the XRT forward model used in this work:

$$F_{\theta,\tau}^T(\mathcal{W}) = \sum_{v} L_{\theta,\tau}^v \mu_v^E \mathcal{W}_{\theta,\tau}. \quad (3.3)$$

We similarly take the logarithm of the raw XRT sinograms used in this paper.

3.2. XRF Imaging Model

Our discrete model follows an elemental approach, in the sense that we model the XRF energy emitted from a single elemental atom by its corresponding elemental unit spectrum. Then, justified by the fact that photon counts are additive, the total XRF spectrum detected from the given sample is estimated as a weighted sum of the unit spectra of the elements being recovered.

First, we model the net XRF intensity $I_{e,\ell,s}$, which corresponds to the characteristic XRF energy $E_e$ emitted from element $e$, by Sherman’s equation [34] up to first order (i.e., neglecting effects such as Rayleigh and Compton scattering):

$$I_{e,\ell,s} = I_0 c_e \omega_{e,\ell} \left( 1 - \frac{1}{r_{e,s}} \right) \mu_v^E, \quad (3.3)$$

where $c_e$ is the total concentration of element $e$ ($c_e = 1$ in the case of our unit spectra), $\omega_{e,\ell}$ is the XRF yield of $e$ for the spectral line $\ell$, and $r_{e,s}$ is the probability that a shell $s$ electron (rather than other shell electrons) will be ejected.

In our calculations, the quantity $\omega_{e,\ell} \left( 1 - \frac{1}{r_{e,s}} \right) \mu_v^E$ is approximated by the XRF cross sections provided from xraylib [35]. Next, we convert the intensity to a spectrum by incorporating
the practical experimental environment. Given an energy-dispersive XRF detector with energy
counts, we follow a maximum likelihood approach that assumes the measurements are subject to
independent Poisson

Then we have the ideal, delta-function peak $P_{\theta,\tau}(\omega) = I_{\theta,\tau} \delta_{\omega}$. In practice, because of the detector
energy resolution [2], discrete x-ray lines get broadened by a Gaussian distribution with a
standard deviation $\sigma$. The resulting unit spectrum of element $e$ is thus given by $M_e = \sum_{\ell,s} M_{e,\ell,s}$, where

$$M_{e,\ell,s} = \mathcal{F}^{-1} \left( \mathcal{F} (I_{\theta,\tau}^{1/2}) \right)$$

and where $\odot$ denotes pointwise (Hadamard product) multiplication and $\mathcal{F} (\mathcal{F}^{-1})$ is the (in-
verse) Fourier transform. To simplify the model, we consider only the

We then model the total XRF spectrum of a sample with multiple elements by explicitly
considering the attenuation of the beam energy and the self-absorption effect of the XRF energy.
We represent the attenuation experienced by beamlet $(\theta, \tau)$ (at incident beam energy $E$) as it
travels toward voxel $v$ by

$$A^E_{\theta,\tau} = \exp \left( - \sum_{\theta'} \frac{P_{\theta',\tau}}{\mu_{\theta'} E^\tau_{\theta'}} \left[ \mathbb{1}(X_{\theta'}) \right] \right)$$

where $\mathbb{1}_{\omega}$ is the indicator (Dirac delta) function for the event $X$ and $\mathbb{1}_{\omega}$ is the set of voxels
that are intersected by beamlet $(\theta, \tau)$ before it enters voxel $v$.

We let $P_{\theta,\tau}(\omega)$ be the attenuation of XRF energy emitted from element $e$ at voxel $v$ by
beamlet $(\theta, \tau)$. To reduce the complexity of the calculation, instead of tracking all the emitted
photons isotropically, we consider only the emission from the region $\Omega_i$. This region is the part
of the sample discretization that intersects the pyramid determined by the centroid of the voxel $v$ and the XRF detector endpoints; see Fig. 1 for a 2D illustration. In a slight abuse of notation, we let $v' \in \Omega_i$ indicate that the centroid of voxel $v'$ is contained in the region $\Omega_i$. Then the
self-absorbed XRF energy is approximated by

$$P_{\theta,\tau} = \exp \left( - \sum_{v' \in \Omega_i} \sum_{e' \in \Omega_i} \mathbb{1} (X_{e'}) \alpha_{e'} \right)$$

where $\alpha_{e'}$ is the volume of $\Omega$ (or area of $\Omega$ for a 2D sample) and $\mu_{e'}$ is the linear attenuation
coefficient of element $e'$ at the XRF energy $E_e$ of element $e$. Accordingly, the fluorescence spectrum $F_{\theta,\tau}$ (in counts/sec) of the sample resulting from beamlet $(\theta, \tau)$ is the $|\mathcal{F}|$-dimensional

$$F_{\theta,\tau}(\omega) = \sum_{e} \left( \sum_{v} A_{\theta,\tau} \right) p_{\theta,\tau} (\omega) \mu_{e} M_e.$$

4. Optimization-Based Reconstruction Formulations and Algorithms

We take $D_{\theta,\tau} \in \mathbb{R}$ and $D_{\theta,\tau} \in \mathbb{R}^{|\mathcal{F}|}$ to denote the experimental data for XRT and XRF,
respectively. We now solve reconstruction problems involving the models $F_{\theta,\tau}(\omega)$ and $F_{\theta,\tau}(\omega)$.
Given that both these source terms are derived from measured photon counts, we follow a
maximum likelihood approach that assumes the measurements are subject to independent Poisson
noise [37, 38]. First, we take a logarithm of $\tilde{D}_{\theta, \tau}^R$ and work with $D_{\theta, \tau}^T = -\ln(\tilde{D}_{\theta, \tau}^R / I_0)$. Maximizing the likelihood (derived in App. A) for our joint inverse problem then can be written as

$$\min_{\mathcal{W} \geq 0} \phi(\mathcal{W}), \tag{4.8}$$

where the non-negativity constraint $\mathcal{W} \geq 0$ is enforced to respect the physical nature of mass;

$$\phi(\mathcal{W}) = \hat{\phi}^R(\mathcal{W}) + \hat{\phi}^T(\mathcal{W}) = \sum_{\theta, \tau} (F_{\theta, \tau}^R(\mathcal{W}) - \ln (F_{\theta, \tau}^R(\mathcal{W})) D_{\theta, \tau}^R) + \beta_1 \sum_{\theta, \tau} (F_{\theta, \tau}^T(\mathcal{W}) - \ln (F_{\theta, \tau}^T(\mathcal{W})) \beta_2 D_{\theta, \tau}^T);$$

$\hat{\phi}^R$ and $\hat{\phi}^T$ correspond to the XRF and XRT objective terms, respectively; and $\beta_1 \geq 0$, $\beta_2 \geq 0$ are scaling parameters. The scaling parameter $\beta_1$ balances the ability of each modality to fit the data, and $\beta_2$ detects the relative variability between the data sources $D_{\theta, \tau}^R$ and $D_{\theta, \tau}^T$.

Advances in x-ray sources, optics, and detectors mean that the datasets to be analyzed can be large; thus, having a fast and memory-efficient algorithm to solve (4.8) is highly desirable. Therefore, we apply an alternating direction approach described in Alg. 1. In this approach, instead of directly minimizing Eq. 4.8, we first solve an “inner iteration” subproblem:

$$\min_{\mathcal{W} \geq 0} \phi^i(\mathcal{W}), \tag{4.9}$$

with

$$\phi^i(\mathcal{W}) = \sum_{\theta, \tau} \sum_{c,v} L_{v,c}^{\theta, \tau} A_{c,v}^{\theta, \tau}(\mathcal{W}^i) M_{c,v} D_{\theta, \tau}^R,$$

and where $A(\mathcal{W}^i)$ and $P(\mathcal{W}^i)$ are fixed given the current solution $\mathcal{W}^i$ at the “outer” iteration $i$ of Alg. 1.

To approximately solve Eq. 4.9, we adapt a form of the inexact truncated Newton (TN) method in [39]. We write TN as a function of the form

$$\mathcal{W}^{i+1} = \text{TN}(\phi^i(\mathcal{W}), \mathcal{W}^i, k),$$

which applies $k$ iterations of TN to the problem in Eq. 4.9 with initial guess $\mathcal{W}^i$ to obtain $\mathcal{W}^{i+1}$. In particular, we use a bound-constrained preconditioned conjugate gradient method to obtain the search direction, followed by a backtracking line search (see Alg. 2) to obtain the next iterate $\mathcal{W}^{i+1}$. The process is repeated until desired stopping criteria are satisfied; in Alg. 1 we repeat until consecutive iterates are within a user-specified distance $\varepsilon$ of one another. Since the focus of this work is to show the potential of joint inversion with multimodal data, future work will address convergence analysis of Alg. 1.

5. Experimental Reconstruction
Algorithm 1 Algorithm for Solving Joint Inversion with Linearized XRF Term.

1: Given tolerance $\varepsilon > 0$ and initial $\mathbf{w}^0$; initialize iteration counter $i = 0$.
2: repeat
3: \[ [\mathbf{A'}, \mathbf{P'}] = \mathbf{F}_{\theta, \tau}(\mathbf{w}^i). \]
4: \[ \mathbf{w}^{i+1} = \text{TN}(\phi^i(\mathbf{w}), \mathbf{w}^i, 50). \]
5: Compute the search direction $e^i = \mathbf{w}^{i+1} - \mathbf{w}^i$.
6: Use backtracking line search $\alpha = \text{LIN}_{\text{NAIVE}}(e^i, \mathbf{w}^i, \phi, 1)$ (see Alg. 2) to obtain $\mathbf{w}^{i+1} = \mathbf{w}^i + \alpha e^i$.
7: $i \leftarrow i + 1$.
8: until $\|\mathbf{w}^{i+1} - \mathbf{w}^i\| < \varepsilon$

Algorithm 2 Backtracking Line Search

1: procedure $\alpha = \text{LIN}_{\text{NAIVE}}(d, x, f, \alpha_{\text{max}})$
2: repeat
3: $\alpha_{\text{max}} \leftarrow \frac{\alpha_{\text{max}}}{2}$.
4: until $f(x + \alpha_{\text{max}}d) < f(x)$, then $\alpha = \alpha_{\text{max}}$
5: end procedure

We now demonstrate the benefit of the proposed joint inversion approach by using experimental data. We constructed a simple test sample consisting of a borosilica glass rod with a composition as described in Sec. 2, wrapped with a a W wire of 10 $\mu$m diameter, and a Au wire of 10 $\mu$m diameter. This test specimen was scanned by an incident beam energy of 12.1 keV at beamline 2-ID-E at the Advanced Photon Source at Argonne National Laboratory. Each projection was acquired by raster scanning with a 200 nm scanning step size and 73 scanning angles over an angular range of 360 °. At each scanning step, the transmission signal was acquired by using a segmented photon diode located downstream of the sample, while the fluorescence signals were collected by using an energy-dispersive detector (Vortex ME-4) located at 90° relative to the incident beam, covering an energy range of 0–20 keV with 2,000 energy channels. The final XRT data contains 73 projections with each slice involving $1,750 \times 51$ pixels, leading to a total data set of dimension $73 \times 1,750 \times 51 \times 2,000$.

As expected from the attenuation lengths given in Table 1 and the simulations shown in Fig. 2, this dataset shows strong self-absorption in the Si fluorescence measurements. We compare our reconstruction result with the output of TomoPy 0.1.15 [40], a widely used tomographic data-processing and image reconstruction library. TomoPy takes the elemental concentration map decomposed from the raw spectrum by the program MAPS 1.2 [12] for improved photon statistics compared with the raw data. The MAPS program fits the full energy spectrum recorded at each scan to a set of x-ray fluorescence peaks plus background signals, and it returns a 2D dataset corresponding to a certain elemental concentration per scan. Figure 3 shows three elemental XRF sinograms of interest as calculated by this approach. Within TomoPy, we used a maximum likelihood expectation maximization algorithm to reconstruct the three sinograms separately. All numerical experiments are performed on a platform with 1.5 TB DDR3 memory and four Intel E7-4820 Xeon CPUs.

For the purposes of algorithm testing with reduced computational cost, we reconstructed only a 2D middle slice $(x, z)$ of the 3D glass rod dataset $(x, y, z)$. For each angle, we summed together 9 adjacent $y$ slices of both XRF spectra and XRT measurements as the input experiment data. Therefore, in our illustration, $|\theta| = 73$, $|\tau| = 196$, and $|\mathcal{V}| = (|\tau| - 1) \times (|\tau| - 1)$. 
Fig. 3: Relative elemental concentrations obtained from a MAPS-based fit of the raw x-ray fluorescence data for the glass rod sample. Due to the imperfection of fitting and background rejection (which might be able to be corrected with additional expert input), the decomposed elemental concentrations show certain artifacts, where certain elemental sinograms pick up other elements’ signals. For example, according to the ground truth, we know that Si exists only in the rod part with a cylinder shape; but its corresponding sinogram shows that it also exists in the two wires, which is caused by imperfect data fitting. Those two extra waves are actually picked up from Au and W signals because certain emission lines of Au and W overlap those of Si.

Fig. 4: Experimental sinograms. Left: mean (across energy channels) value of XRF raw spectrum; Right: XRT sinogram. Based on the different magnitudes of these two datasets, we choose $\beta_2 = 10$ as the scaling parameter to balance the measurement variability of the two data sources, so that both measurements have maxima near 10 in their respective units. As a result, the relative variability of the two detectors between the data sources is mitigated.
5.1. Selection of $\beta$ Values

Next, we explain one way to select values for $\beta_1$ and $\beta_2$ for use in the objective in Eq. 4.8. We recall that the effect of $\beta_2$ is to balance the magnitudes of the XRF and XRT measurement data, and that its exact value is not critical. Therefore, according to the magnitude difference of two data sources shown in Fig. 4, we chose to use $\beta_2 = 10$ to balance this difference so that both measurements have maxima near 10 in their respective units. The selection of $\beta_1$ is accomplished by applying the so-called L-curve method [41]. In Fig. 5a, we plot the L-curve defined by the curve of XRT terms $\tilde{\phi}_T$ versus XRF terms $\tilde{\phi}_R$ obtained from solving Eq. 4.8 with different $\beta_1$ values. This curve displays the tradeoffs between these two modalities and provides an aid in choosing an appropriate balancing parameter $\beta_1$. The curvature, defined as the curvature of a circle drawn through three successive points on the L-curve, is calculated and plotted in Fig. 5b. As suggested by [41], we choose the point on the L-curve with the maximum curvature; according to Fig. 5, this is $\beta_1 = 1$. Consistently, Fig. 9 shows the reconstructed elemental maps corresponding to different $\beta_1$, and $\beta_1 = 1$ returns the results that are closest to the ground truth.

5.2. Joint Inversion Results

Given $\mathcal{W}^0 = 0$ as the initial guess for the joint inversion, Fig. 6 shows the reconstruction result for each element by using Alg. 1 with $\varepsilon = 10^{-6}$. In particular, Fig. 7 shows the performance of the inner iteration by TN to reduce both the XRF and XRT objective values. Correspondingly, Fig. 8 shows the reconstructed result of each outer iteration of Alg. 1. The reconstructed elemental maps show the benefits of our joint inversion mainly from two perspectives. First, because of the imperfections of spectral fitting and background rejection, the decomposed elemental concentrations show certain artifacts—which we call the “shadow effect”—where certain elemental sinograms pick up other elements’ signals. For example, according to the ground truth, we know that Si exists only in the rod part with a cylinder shape; but its corresponding sinogram from MAPS, shown in Fig. 3, shows that it also exists in the two wires, which is caused by imperfect data fitting. Those two extra waves are actually picked up from Au and W signals because certain emission lines of Au and W overlap those of Si. As a result, the reconstruction from TomoPy based on these decomposed sinograms will contain the “shadow points,” which
Fig. 6: Comparison of reconstruction results for MAPS+TomoPy, XRF alone, and joint reconstruction, respectively, given an initial guess of all zeros, $\beta_1 = 1$, and $\beta_2 = 10$. Every elemental map is rescaled to the range $[0, 0.25]$. It is clear that the joint reconstruction returns the best result from two perspectives: first, the glass rod is filled with Si; and second, the “shadow effect” is dramatically mitigated for the reconstruction of Si and W.

Fig. 7: Convergence of TN for each inner iteration $j$, given a maximum number of inner iterations as 50, $\beta_1 = 1$, and $\beta_2 = 10$. We can see that along the iterations, TN is reducing the objective function so that the forward model fits better and better to the given data.
Fig. 8: Solution for each outer iteration $i$, given $(\beta_1, \beta_2) = (1, 10)$. At iteration $i = 3$, Alg. 1 reaches its stopping criterion in the sense that the solution does not change anymore. It also indicates that our alternating algorithm is very efficient to converge to the solution within only a few iterations.
Fig. 9: Reconstruction results (given $\beta_2 = 10$) for different $\beta_1$ values. The results are consistent with the L-curve plotted in Fig. 5: $\beta_1 = 1$ returns the solution set closest to the ground truth. Therefore, with a reasonable $\beta_1$ provided by the L-curve method, the joint reconstruction is able to return a dramatic improvement on the reconstruction quality.
are shown as two small dots around Si and a dot in the W map in the left bottom corner of Fig. 6. Comparing the results from XRF single inversion using our forward model with the TomoPy output, we see that our forward model is able to better distinguish the different elemental signals; that is, the “shadow effect” is greatly mitigated. Furthermore, by introducing the XRT modality into the reconstruction, the joint inversion not only suppressed the artifacts from the “shadow effect” and the strikes introduced by the misalignment between projections but also more accurately recovered Si by filling the inside of the cylinder and thereby correcting the self-absorption effect. Also, we provide a quantity evaluation of our reconstruction. We simulate the XRF spectrum based on the reconstructed elemental composition and compare it to the real experimental data as shown in Fig. 10. We can see that, except the background region that our forward model does not include to simulate, the essential peaks corresponding to the main elements we are interested to cover agree very well with the experimental data. This comparison indicates that not only our joint reconstruction improves the solution from a visualization perspective, but also from quantification point of view. Furthermore, it indicates a satisfying accuracy of our XRF forward model.

6. Conclusion
Guided by the multimodal analysis methodology developed in [32], we apply a joint-inversion framework to solve XRF reconstruction problem more accurately by incorporating a second data modality as XRT. We investigate the correlations between XRF and XRT data, and establish a link between datasets by reformulating their models so that they share a common set of unknown variables. We develop an iterative algorithm by alternatively maximizing a Poisson likelihood objective to estimate the unknown elemental distribution, and then updating the self-absorption term in the forward model. The numerical results presented in the paper show that when facing strong self-absorption effects, significant improvements are achieved by performing joint inversion. Furthermore, because of the improved accuracy provided by our XRF forward model, the artifacts arising from the “shadow effect” are greatly mitigated.

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A. Maximum Likelihood Derivation

We assume that the measurement data are independent and that each measurement $D_j$ follows a Poisson distribution with mean $F_j(\mathcal{W})$. The likelihood for any $D_j$ is then

$$f(D_j; F_j(\mathcal{W})) = \Pr(X = D_j) = \frac{(F_j(\mathcal{W}))^{D_j} \exp\{-F_j(\mathcal{W})\}}{D_j!}.$$ 

By the assumed independence of the measurements, the joint likelihood is

$$\prod_j f(D_j; F_j(\mathcal{W})).$$

The problem of maximizing the log likelihood is thus

$$\max_{\mathcal{W}} \ln(\prod_j f(D_j; F_j(\mathcal{W})))$$

$$= \sum_j \ln(f(D_j; F_j(\mathcal{W})))$$

$$= \sum_j \ln \left( \frac{(F_j(\mathcal{W}))^{D_j} \exp\{-F_j(\mathcal{W})\}}{D_j!} \right)$$

$$= \sum_j \left( \ln(F_j(\mathcal{W})^{D_j}) + \ln(\exp\{-F_j(\mathcal{W})\}) - \ln(D_j!) \right).$$

Since each $D_j$ is a scalar (independent of $\mathcal{W}$), it is therefore equivalent to solve

$$\max_{\mathcal{W}} \psi(\mathcal{W}) = \sum_j (D_j \ln(F_j(\mathcal{W})) - F_j(\mathcal{W})). \quad (A.10)$$

Our approach requires first-order derivatives, which are easily derived in the Poisson noise setting. For a particular (voxel $v$, element $e$) pair, the first-order derivative of (A.10) with respect to the concentration $\mathcal{W}_{v,e}$ is

$$\frac{\partial}{\partial \mathcal{W}_{v,e}} \psi(\mathcal{W}) = \sum_j \left( \frac{D_j}{F_j(\mathcal{W})} - 1 \right) \frac{\partial}{\partial \mathcal{W}_{v,e}} F_j(\mathcal{W}).$$

The calculation of the remaining derivatives $\frac{\partial}{\partial \mathcal{W}_{v,e}} F_j(\mathcal{W})$ is described in our previous paper [32].